

2N828 (continued)

ELECTRICAL CHARACTERISTICS (continued)

Characteristic	Symbol	Min	Typ	Max	Unit
DYNAMIC CHARACTERISTICS					
Current-Gain — Bandwidth Product ($I_C = 10\text{ mA}$ dc, $V_{CE} = 1\text{ V}$ dc, $f = 100\text{ MHz}$)	f_T	300	400	-	MHz
Output Capacitance ($V_{CB} = 10\text{ V}$ dc, $I_E = 0$)	C_{ob}	-	3.5	-	pF
Small Signal Current Gain ($I_C = 10\text{ mA}$ dc, $V_{CE} = 1\text{ V}$ dc, $f = 100\text{ MHz}$)	h_{fe}	3	4.0	-	-
Delay Plus Rise Time (Figure 1)	$t_d + t_r$	-	50	70	ns
Storage Time (Figure 1)	t_s	-	33	50	ns
Fall Time (Figure 1)	t_f	-	35	50	ns
Charge Storage Time Constant (Figure 2)	τ_s	-	14	25	ns
Rise Time (Figure 3)	t_r	-	7.0	-	ns
Storage Time (Figure 4)	t_s	-	5.0	-	ns
Fall Time (Figure 4)	t_f	-	3.0	-	ns

2N828A (GERMANIUM)

2N829

CASE 22
(TO-18)



PNP germanium epitaxial mesa transistors for high-speed switching applications

Collector connected to case
MAXIMUM RATINGS

Rating	Symbol	Value	Unit
Collector to Base Voltage	V_{CB}	15	Vdc
Collector to Emitter Voltage	V_{CES}	15	Vdc
Emitter to Base Voltage	V_{EB}	2.5	Vdc
Collector Current (Continuous)	I_C	200	mA
Total Device Dissipation at 25°C case Temperature (Derate 4.0mW/°C above 25°C)	P_D	300	mW
Total Device Dissipation at 25°C Ambient Temperature (Derate 2.0mW/°C)	P_D	150	mW
Junction Temperature	T_J	+100	°C
Storage Temperature	T_{stg}	-65 to +100	°C

2N828A, 2N829 (continued)

ELECTRICAL CHARACTERISTICS (T_A = 25°C unless otherwise noted)

Characteristic	Symbol	Min	Typ	Max	Unit
Collector to Base Breakdown Voltage I _E = 0, I _C = 100μAdc	BV _{CBO}	15	25	--	Vdc
Collector to Emitter Breakdown Voltage V _{EB} = 0, I _C = 100μAdc	BV _{CES}	15	25	--	Vdc
Emitter to Base Breakdown Voltage I _C = 0, I _E = 100μAdc	BV _{EBO}	2.5	--	--	Vdc
Collector Cutoff Current I _E = 0, V _{CB} = 6Vdc	I _{CBO}	--	0.4	3.0	μAdc
Forward Current Transfer Ratio I _C = 10mAdc, V _{CE} = 0.3Vdc 2N828A 2N829	h _{FE}	25 50	40 80	--	--
Forward Current Transfer Ratio I _C = 150mAdc, V _{CE} = 1Vdc 2N828A 2N829	h _{fe}	25 50	40 80	--	--
Collector Saturation Voltage I _C = 10mAdc, I _B = 1.0mAdc I _C = 10mAdc, I _B = 0.5mAdc 2N828A 2N829	V _{CE(sat)}	--	0.11 0.11	0.20 0.20	Vdc
Collector Saturation Voltage I _C = 50mAdc, I _B = 5.0mAdc	V _{CE(sat)}	--	--	0.25	Vdc
Collector Saturation Voltage I _C = 150mAdc, I _B = 15mAdc I _C = 150mAdc, I _B = 7.5mAdc 2N828A 2N829	V _{CE(sat)}	--	0.35 0.38	0.50 0.50	Vdc
Base to Emitter Voltage I _C = 10mAdc, I _B = 1mAdc I _C = 10mAdc, I _B = 0.5mAdc 2N828A 2N829	V _{BE}	0.34 0.30	0.40 0.38	0.44 0.44	Vdc
Base to Emitter Voltage I _C = 150mAdc, I _B = 15mAdc I _C = 150mAdc, I _B = 7.5mAdc 2N828A 2N829	V _{BE}	--	0.70 0.65	0.85 0.85	Vdc
Collector Capacitance I _E = 0, V _{CB} = 6Vdc, f = 100 kHz)	C _{ob}	--	2.2	4.0	pF

2N828A, 2N829 (continued)
ELECTRICAL CHARACTERISTICS (continued)

Characteristic	Symbol	Min	Typ	Max	Unit
Input Capacitance $V_{BE} = 1Vdc, I_E = 0, f = 100 \text{ kHz}$	C_{ib}	--	2.2	3.5	pF
Small Signal Forward Current Transfer Ratio $I_C = 10mAdc, V_{CE} = -1Vdc, f = 100 \text{ MHz}$	h_{fe}	3.0	4.0	--	--
Current Gain Bandwidth Product $V_{CE} = 1Vdc, I_C = -10mAdc, f = 100 \text{ MHz}$	f_T	300	400	--	MHz
Delay Plus Rise Time (Fig. 1) $I_C = 10mAdc$	$t_d + t_r$	--	35	50	ns
Storage Time (Fig. 1) $I_C = 10mAdc$	t_s	--	30	50	ns
Fall Time (Fig. 1) $I_C = 10mAdc$	t_f	--	30	50	ns
Total Control Charge (Fig. 3) $I_C = 10mAdc$	Q_T	--	50	80	pC
Delay Plus Rise Time (Fig. 2) $I_C = 150mAdc$	$t_d + t_r$	--	25	50	ns
Turn Off Time (Fig. 2) $I_C = 150mAdc$	t_{off}	--	60	100	ns
Total Control Charge (Fig. 4) $I_C = 150mAdc$	Q_T	--	120	175	pC

FIGURE 1 — 10mA SWITCHING TIME TEST CIRCUIT

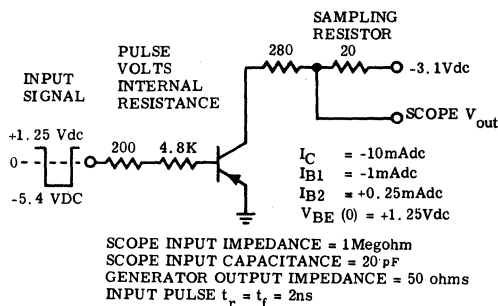


FIGURE 2 — 150mA SWITCHING TIME TEST CIRCUIT

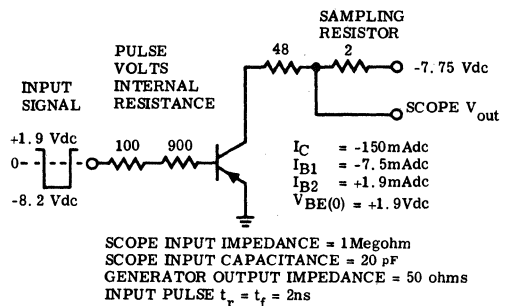


FIGURE 3 — 10mA TOTAL CONTROL CHARGE TEST CIRCUIT

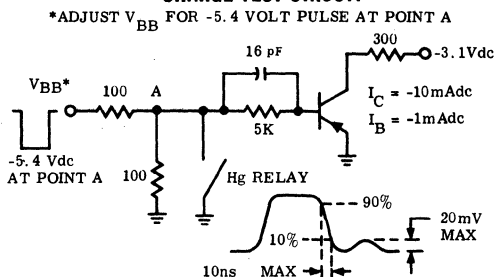


FIGURE 4 — 150mA TOTAL CONTROL CHARGE TEST CIRCUIT

